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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

Product Status	Obsolete
Number of LABs/CLBs	-
Number of Logic Elements/Cells	1024
Total RAM Bits	8192
Number of I/O	62
Number of Gates	30000
Voltage - Supply	3V ~ 3.6V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C
Package / Case	84-LCC (J-Lead)
Supplier Device Package	84-PLCC (29.31x29.31)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/at40k20al-1ajc">https://www.e-xfl.com/product-detail/microchip-technology/at40k20al-1ajc</a>

**Table 1.** AT40KAL Family<sup>(1)</sup>

Device	AT40K05AL	AT40K10AL	AT40K20AL	AT40K40AL
Usable Gates	5K - 10K	10K - 20K	20K - 30K	40K - 50K
Rows x Columns	16 x 16	24 x 24	32 x 32	48 x 48
Cells	256	576	1,024	2,304
Registers	496 <sup>(1)</sup>	954 <sup>(1)</sup>	1,520 <sup>(1)</sup>	3,048 <sup>(1)</sup>
RAM Bits	2,048	4,608	8,192	18,432
I/O (Maximum)	128	192	256	384

Note: 1. Packages with FCK will have 8 less registers.

## Description

The AT40KAL is a family of fully PCI-compliant, SRAM-based FPGAs with distributed 10 ns programmable synchronous/asynchronous, dual-port/single-port SRAM, 8 global clocks, Cache Logic ability (partially or fully reconfigurable without loss of data), automatic component generators, and range in size from 5,000 to 50,000 usable gates. I/O counts range from 128 to 384 in industry standard packages ranging from 84-pin PLCC to 352-ball Square BGA, and support 3.3V designs.

The AT40KAL is designed to quickly implement high-performance, large gate count designs through the use of synthesis and schematic-based tools used on a PC or Sun platform. Atmel's design tools provide seamless integration with industry standard tools such as Synplicity, ModelSim, Exemplar and Viewlogic. See the "IDS Datasheet" available on the Atmel web site (<http://www.atmel.com/atmel/acrobat/doc1421.pdf>) for a list of other supported tools.

The AT40KAL can be used as a coprocessor for high-speed (DSP/processor-based) designs by implementing a variety of computation intensive, arithmetic functions. These include adaptive finite impulse response (FIR) filters, fast Fourier transforms (FFT), convolvers, interpolators and discrete-cosine transforms (DCT) that are required for video compression and decompression, encryption, convolution and other multimedia applications.

## Fast, Flexible and Efficient SRAM

The AT40KAL FPGA offers a patented distributed 10 ns SRAM capability where the RAM can be used without losing logic resources. Multiple independent, synchronous or asynchronous, dual-port or single-port RAM functions (FIFO, scratch pad, etc.) can be created using Atmel's macro generator tool.

## Fast, Efficient Array and Vector Multipliers

The AT40KAL's patented 8-sided core cell with direct horizontal, vertical and diagonal cell-to-cell connections implements ultra fast array multipliers without using any busing resources. The AT40KAL's Cache Logic capability enables a large number of design coefficients and variables to be implemented in a very small amount of silicon, enabling vast improvement in system speed at much lower cost than conventional FPGAs.

## Cache Logic Design

The AT40KAL, AT6000 and FPSLIC families are capable of implementing Cache Logic (dynamic full/partial logic reconfiguration, without loss of data, on-the-fly) for building adaptive logic and systems. As new logic functions are required, they can be loaded into the logic cache without losing the data already there or disrupting the operation of the rest of the chip; replacing or complementing the active logic. The AT40KAL can act as a reconfigurable coprocessor.

## Automatic Component Generators

The AT40KAL FPGA family is capable of implementing user-defined, automatically generated, macros in multiple designs; speed and functionality are unaffected by the macro orientation or density of the target device. This enables the fastest, most predictable and efficient FPGA design approach and minimizes design risk by reusing already proven functions. The Automatic Component Generators work seamlessly with industry standard schematic and synthesis tools to create the fastest, most efficient designs available.

The patented AT40KAL series architecture employs a symmetrical grid of small yet powerful cells connected to a flexible busing network. Independently controlled clocks and resets govern every column of cells. The array is surrounded by programmable I/O.

Devices range in size from 5,000 to 50,000 usable gates in the family, and have 256 to 3,048 registers. Pin locations are consistent throughout the AT40KAL series for easy design migration in the same package footprint. The AT40KAL series FPGAs utilize a reliable 0.35 $\mu$  triple-metal, CMOS process and are 100% factory-tested. Atmel's PC- and workstation-based integrated development system (IDS) is used to create AT40KAL series designs. Multiple design entry methods are supported.

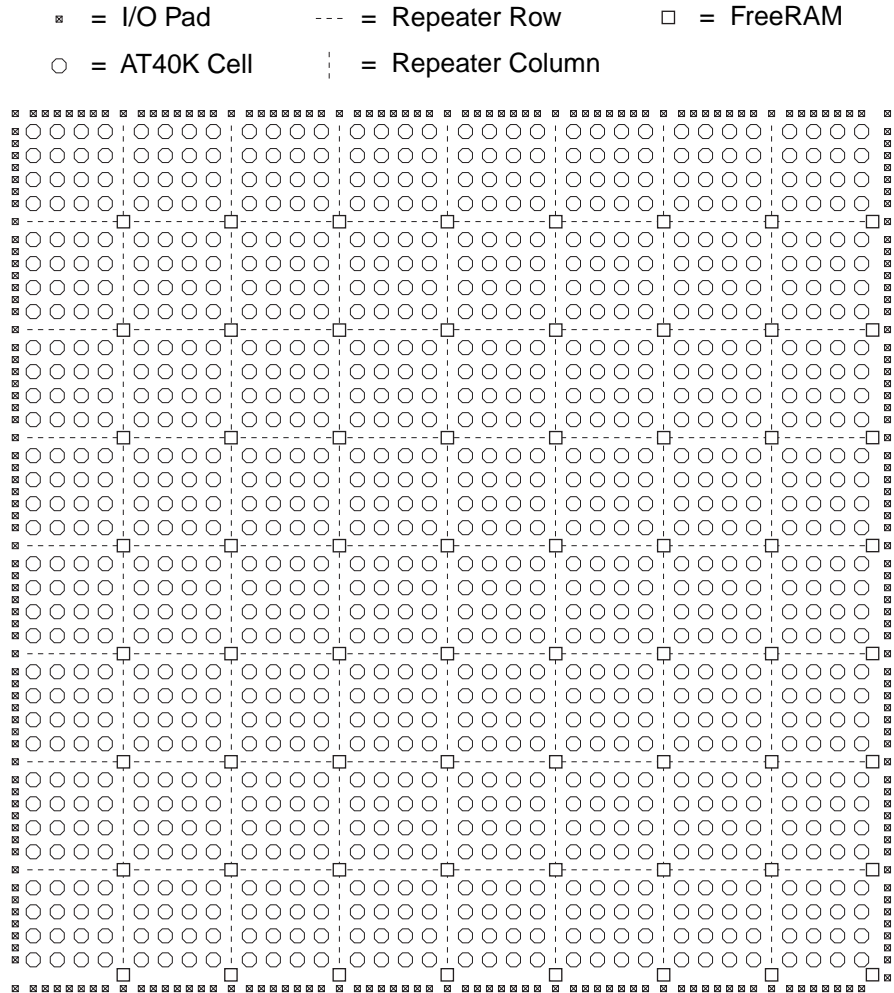
The Atmel architecture was developed to provide the highest levels of performance, functional density and design flexibility in an FPGA. The cells in the Atmel array are small, efficient and can implement any pair of Boolean functions of (the same) three inputs or any single Boolean function of four inputs. The cell's small size leads to arrays with large numbers of cells, greatly multiplying the functionality in each cell. A simple, high-speed busing network provides fast, efficient communication over medium and long distances.

## The Symmetrical Array

At the heart of the Atmel architecture is a symmetrical array of identical cells, see Figure 1. The array is continuous from one edge to the other, except for bus repeaters spaced every four cells, see Figure 2 on page 5. At the intersection of each repeater row and column there is a 32 x 4 RAM block accessible by adjacent buses. The RAM can be configured as either a single-ported or dual-ported RAM<sup>(1)</sup>, with either synchronous or asynchronous operation.

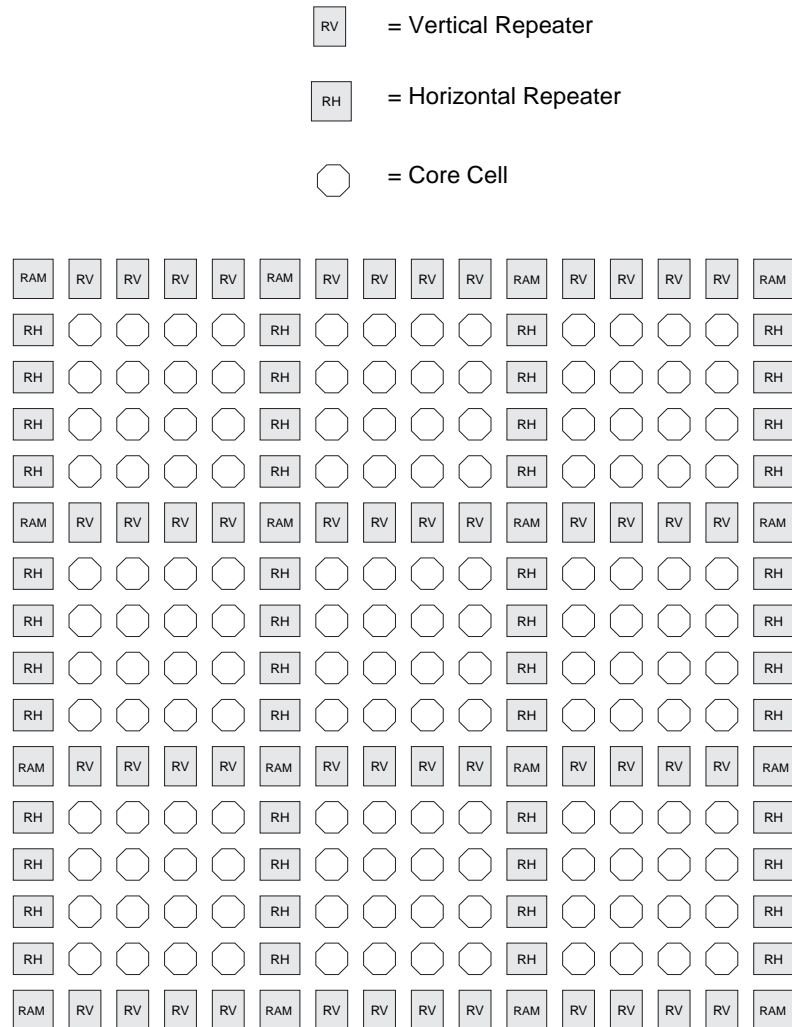
Note: 1. The right-most column can only be used as single-port RAM.

**Figure 1. Symmetrical Array Surrounded by I/O (AT40K20AL)<sup>(1)</sup>**



Note: 1. AT40KAL has registered I/Os. Group enable on every sector for tri-states on obufe's.

**Figure 2. Floor Plan (Representative Portion)<sup>(1)</sup>**



Note: 1. Repeaters regenerate signals and can connect any bus to any other bus (all pathways are legal) on the same plane. Each repeater has connections to two adjacent local-bus segments and two express-bus segments. This is done automatically using the integrated development system (IDS) tool.

## The Busing Network

Figure 3 on page 7 depicts one of five identical busing planes. Each plane has three bus resources: a local-bus resource (the middle bus) and two express-bus (both sides) resources. Bus resources are connected via repeaters. Each repeater has connections to two adjacent local-bus segments and two express-bus segments. Each local-bus segment spans four cells and connects to consecutive repeaters. Each express-bus segment spans eight cells and “leapfrogs” or bypasses a repeater. Repeaters regenerate signals and can connect any bus to any other bus (all pathways are legal) on the same plane. Although not shown, a local bus can bypass a repeater via a programmable pass gate allowing long on-chip tri-state buses to be created. Local/Local turns are implemented through pass gates in the cell-bus interface. Express/Express turns are implemented through separate pass gates distributed throughout the array.

Some of the bus resources on the AT40KAL are used as a dual-function resources. Table 2 shows which buses are used in a dual-function mode and which bus plane is used. The AT40KAL software tools are designed to accommodate dual-function buses in an efficient manner.

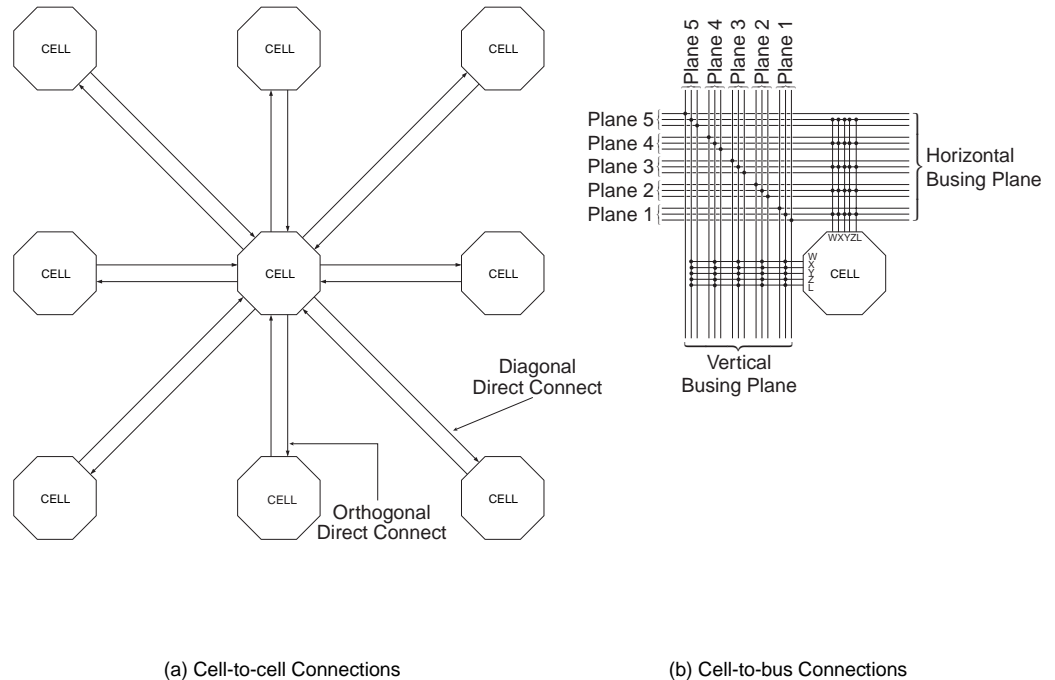
**Table 2.** Dual-function Buses

Function	Type	Plane(s)	Direction	Comments
Cell Output Enable	Local	5	Horizontal and Vertical	
RAM Output Enable	Express	2	Vertical	Bus full length at array edge Bus in first column to left of RAM block
RAM Write Enable	Express	1	Vertical	Bus full length at array edge Bus in first column to left of RAM block
RAM Address	Express	1 - 5	Vertical	Buses full length at array edge Buses in second column to left of RAM block
RAM Data In	Local	1	Horizontal	Data In connects to local bus plane 1
RAM Data Out	Local	2	Horizontal	Data out connects to local bus plane 2
Clocking	Express	4	Vertical	Bus half length at array edge
Set/Reset	Express	5	Vertical	Bus half length at array edge

## Cell Connections

Figure 4(a) depicts direct connections between a cell and its eight nearest neighbors. Figure 4(b) shows the connections between a cell and five horizontal local buses (1 per busing plane) and five vertical local buses (1 per busing plane).

**Figure 4.** Cell Connections



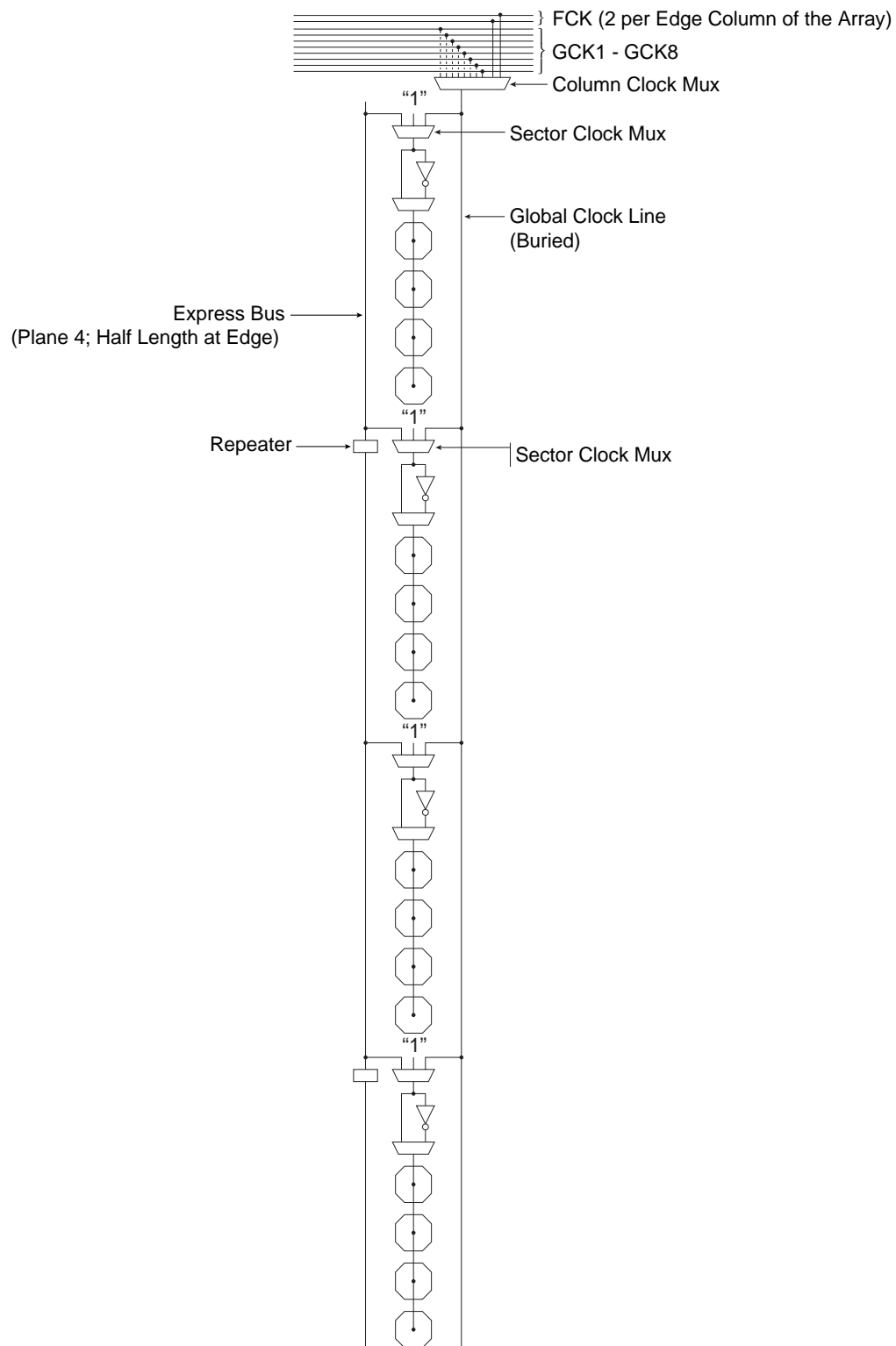
## The Cell

Figure 5 depicts the AT40KAL cell. Configuration bits for separate muxes and pass gates are independent. All permutations of programmable muxes and pass gates are legal.  $V_n$  ( $V_1 - V_5$ ) is connected to the vertical local bus in plane  $n$ .  $H_n$  ( $H_1 - H_5$ ) is connected to the horizontal local bus in plane  $n$ . A local/local turn in plane  $n$  is achieved by turning on the two pass gates connected to  $V_n$  and  $H_n$ . Pass gates are opened to let signals into the cell from a local bus or to drive a signal out onto a local bus. Signals coming into the logic cell on one local bus plane can be switched onto another plane by opening two of the pass gates. This allows bus signals to switch planes to achieve greater route ability. Up to five simultaneous local/local turns are possible.

The AT40KAL FPGA core cell is a highly configurable logic block based around two 3-input LUTs (8 x 1 ROM), which can be combined to produce one 4-input LUT. This means that any core cell can implement two functions of 3 inputs or one function of 4 inputs. There is a Set/Reset D flip-flop in every cell, the output of which may be tri-stated and fed back internally within the core cell. There is also a 2-to-1 multiplexer in every cell, and an upstream AND gate in the “front end” of the cell. This AND gate is an important feature in the implementation of efficient array multipliers.

With this functionality in each core cell, the core cell can be configured in several “modes”. The core cell flexibility makes the AT40KAL architecture well suited to most digital design application areas, see Figure 6.

**Figure 10.** Clocking (for One Column of Cells)





**Primary, Secondary and Corner I/Os**

The AT40KAL has three kinds of I/Os: Primary I/O, Secondary I/O and a Corner I/O. Every edge cell except corner cells on the AT40KAL has access to one Primary I/O and two Secondary I/Os.

**Primary I/O**

Every logic cell at the edge of the FPGA array has a direct orthogonal connection to and from a Primary I/O cell. The Primary I/O interfaces directly to its adjacent core cell. It also connects into the repeaters on the row immediately above and below the adjacent core cell. In addition, each Primary I/O also connects into the busing network of the three nearest edge cells. This is an extremely powerful feature, as it provides logic cells toward the center of the array with fast access to I/Os via local and express buses. It can be seen from the diagram that a given Primary I/O can be accessed from any logic cell on three separate rows or columns of the FPGA. See Figure 12 on page 20.

**Secondary I/O**

Every logic cell at the edge of the FPGA array has two direct diagonal connections to a Secondary I/O cell. The Secondary I/O is located between core cell locations. This I/O connects on the diagonal inputs to the cell above and the cell below. It also connects to the repeater of the cell above and below. In addition, each Secondary I/O also connects into the busing network of the two nearest edge cells. This is an extremely powerful feature, as it provides logic cells toward the center of the array with fast access to I/Os via local and express buses. It can be seen from the diagram that a given Secondary I/O can be accessed from any logic cell on two rows or columns of the FPGA. See Figure 13 on page 20.

**Corner I/O**

Logic cells at the corner of the FPGA array have direct-connect access to five separate I/Os: 2 Primary, 2 Secondary and 1 Corner I/O. Corner I/Os are like an extra Secondary I/O at each corner of the array. With the inclusion of Corner I/Os, an AT40KAL FPGA with  $n \times n$  core cells always has  $8n$  I/Os. As the diagram shows, Corner I/Os can be accessed both from the corner logic cell and the horizontal and vertical busing networks running along the edges of the array. This means that many different edge logic cells can access the Corner I/Os. See Figure 14 on page 21.

## Absolute Maximum Ratings – 3.3V Commercial/Industrial\*

Operating Temperature .....	-55°C to +125°C
Storage Temperature .....	-65°C to +150°C
Voltage on Any Pin with Respect to Ground .....	-0.5V to $V_{CC} + 7V$
Supply Voltage ( $V_{CC}$ ) .....	-0.5V to +7.0V
Maximum Soldering Temp. (10 sec. @ 1/16 in.) .....	250°C
ESD ( $R_{ZAP} = 1.5K$ , $C_{ZAP} = 100$ pF) .....	2000V

\*NOTICE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those listed under operating conditions is not implied. Exposure to Absolute Maximum Rating conditions for extended periods of time may affect device reliability.

## DC and AC Operating Range – 3.3V Operation

		Commercial	Industrial
Operating Temperature (Case)		0°C - 70°C	-40°C - 85°C
$V_{CC}$ Power Supply		3.3V $\pm$ 0.3V	3.3V $\pm$ 0.3V
Input Voltage Level (CMOS)	High ( $V_{IHC}$ )	70% - 100% $V_{CC}$	70% - 100% $V_{CC}$
	Low ( $V_{ILC}$ )	0 - 30% $V_{CC}$	0 - 30% $V_{CC}$

**DC Characteristics – 3.3V Operation Commercial/Industrial**

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Units
$V_{IH}$	High-level Input Voltage	CMOS	$0.7 V_{CC}$		5.5V	V
$V_{IL}$	Low-level Input Voltage	CMOS	-0.3		$30\% V_{CC}$	V
$V_{OH}$	High-level Output Voltage	$I_{OH} = 4 \text{ mA}$ $V_{CC} = V_{CC} \text{ minimum}$	2.1			V
		$I_{OH} = 12 \text{ mA}$ $V_{CC} = 3.0V$	2.1			V
		$I_{OH} = 16 \text{ mA}$ $V_{CC} = 3.0V$	2.1			V
$V_{OL}$	Low-level Output Voltage	$I_{OL} = -4 \text{ mA}$ $V_{CC} = 3.0V$			0.4	V
		$I_{OL} = -12 \text{ mA}$ $V_{CC} = 3.0V$			0.4	V
		$I_{OL} = -16 \text{ mA}$ $V_{CC} = 3.0V$			0.4	V
$I_{IH}$	High-level Input Current	$V_{IN} = V_{CC} \text{ Maximum}$			10.0	$\mu\text{A}$
		With pull-down, $V_{IN} = V_{CC}$	75.0	150.0	300.0	$\mu\text{A}$
$I_{IL}$	Low-level Input Current	$V_{IN} = V_{SS}$	-10.0			$\mu\text{A}$
		With pull-up, $V_{IN} = V_{SS}$	-300.0	-150.0	-75.0	$\mu\text{A}$
$I_{OZH}$	High-level Tri-state Output Leakage Current	Without pull-down, $V_{IN} = V_{CC} \text{ Maximum}$			10.0	$\mu\text{A}$
		With pull-down, $V_{IN} = V_{CC} \text{ Maximum}$	75.0	150.0	300.0	$\mu\text{A}$
$I_{OZL}$	Low-level Tri-state Output Leakage Current	Without pull-up, $V_{IN} = V_{SS}$	-10.0			mA
		With pull-up, $V_{IN} = V_{SS}$	CON = -500 $\mu\text{A}$ TO -125 $\mu\text{A}$	-150.0	CON = -500 $\mu\text{A}$ TO -125 $\mu\text{A}$	$\mu\text{A}$
$I_{CC}$	Standby Current Consumption	Standby, unprogrammed		0.6	1.0	mA
$C_{IN}$	Input Capacitance	All pins			10.0	pF

Note: 1. Parameter based on characterization and simulation; it is not tested in production.

## AC Timing Characteristics – 3.3V Operation

Delays are based on fixed loads and are described in the notes.

Maximum times based on worst case:  $V_{CC} = 3.00V$ , temperature =  $70^{\circ}C$

Minimum times based on best case:  $V_{CC} = 3.60V$ , temperature =  $0^{\circ}C$

Maximum delays are the average of  $t_{PDH}$  and  $t_{PDHL}$ .

Cell Function	Parameter	Path	-1	Units	Notes
<b>Core</b>					
2-input Gate	$t_{PD}$ (Maximum)	x/y -> x/y	1.8	ns	1 unit load
3-input Gate	$t_{PD}$ (Maximum)	x/y/z -> x/y	2.1	ns	1 unit load
3-input Gate	$t_{PD}$ (Maximum)	x/y/w -> x/y	2.2	ns	1 unit load
4-input Gate	$t_{PD}$ (Maximum)	x/y/w/z -> x/y	2.2	ns	1 unit load
Fast Carry	$t_{PD}$ (Maximum)	y -> y	1.4	ns	1 unit load
Fast Carry	$t_{PD}$ (Maximum)	x -> y	1.7	ns	1 unit load
Fast Carry	$t_{PD}$ (Maximum)	y -> x	1.8	ns	1 unit load
Fast Carry	$t_{PD}$ (Maximum)	x -> x	1.5	ns	1 unit load
Fast Carry	$t_{PD}$ (Maximum)	w -> y	2.2	ns	1 unit load
Fast Carry	$t_{PD}$ (Maximum)	w -> x	2.3	ns	1 unit load
Fast Carry	$t_{PD}$ (Maximum)	z -> y	2.3	ns	1 unit load
Fast Carry	$t_{PD}$ (Maximum)	z -> x	1.7	ns	1 unit load
DFF	$t_{PD}$ (Maximum)	q -> x/y	1.8	ns	1 unit load
DFF	$t_{PD}$ (Maximum)	R -> x/y	2.2	ns	1 unit load
DFF	$t_{PD}$ (Maximum)	S -> x/y	2.2	ns	1 unit load
DFF	$t_{PD}$ (Maximum)	q -> w	1.8	ns	
Incremental -> L	$t_{PD}$ (Maximum)	x/y -> L	1.5	ns	1 unit load
Local Output Enable	$t_{PZX}$ (Maximum)	oe -> L	1.4	ns	1 unit load
Local Output Enable	$t_{PXZ}$ (Maximum)	oe -> L	1.8	ns	

## AC Timing Characteristics – 3.3V Operation

Delays are based on fixed loads and are described in the notes.

Maximum times based on worst case:  $V_{CC} = 3.0V$ , temperature =  $70^{\circ}C$

Minimum times based on best case:  $V_{CC} = 3.6V$ , temperature =  $0^{\circ}C$

Maximum delays are the average of  $t_{PDLH}$  and  $t_{PDHL}$ .

All input IO characteristics measured from a  $V_{IH}$  of 50% of  $V_{DD}$  at the pad (CMOS threshold) to the internal  $V_{IH}$  of 50% of  $V_{DD}$ . All output IO characteristics are measured as the average of  $t_{PDLH}$  and  $t_{PDHL}$  to the pad  $V_{IH}$  of 50% of  $V_{DD}$ .

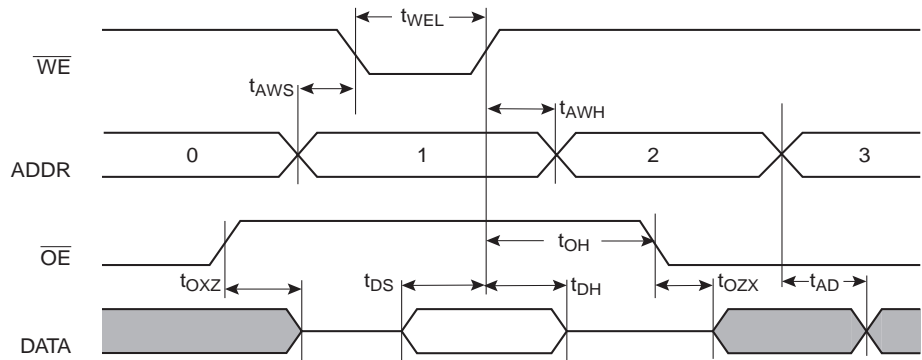
Cell Function	Parameter	Path	-1	Units	Notes
<b>Repeaters</b>					
Repeater	$t_{PD}$ (Maximum)	L -> E	1.3	ns	1 unit load
Repeater	$t_{PD}$ (Maximum)	E -> E	1.3	ns	1 unit load
Repeater	$t_{PD}$ (Maximum)	L -> L	1.3	ns	1 unit load
Repeater	$t_{PD}$ (Maximum)	E -> L	1.3	ns	1 unit load
Repeater	$t_{PD}$ (Maximum)	E -> IO	0.8	ns	1 unit load
Repeater	$t_{PD}$ (Maximum)	L -> IO	0.8	ns	1 unit load

All input IO characteristics measured from a  $V_{IH}$  of 50% of  $V_{DD}$  at the pad (CMOS threshold) to the internal  $V_{IH}$  of 50% of  $V_{DD}$ . All output IO characteristics are measured as the average of  $t_{PDLH}$  and  $t_{PDHL}$  to the pad  $V_{IH}$  of 50% of  $V_{DD}$ .

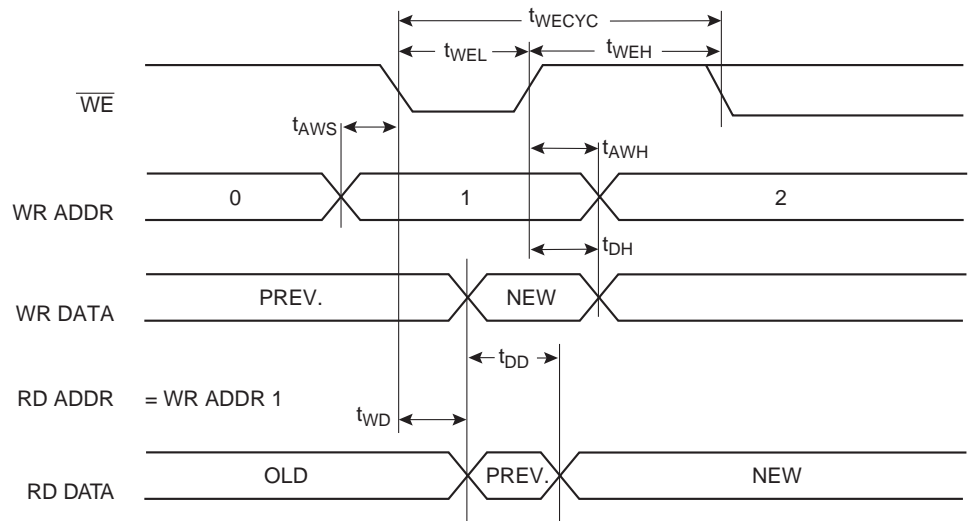
Cell Function	Parameter	Path	-1	Units	Notes
<b>IO</b>					
Input	$t_{PD}$ (Maximum)	pad -> x/y	1.2	ns	No extra delay
Input	$t_{PD}$ (Maximum)	pad -> x/y	3.6	ns	1 extra delay
Input	$t_{PD}$ (Maximum)	pad -> x/y	7.3	ns	2 extra delays
Input	$t_{PD}$ (Maximum)	pad -> x/y	10.8	ns	3 extra delays
Output, Slow	$t_{PD}$ (Maximum)	x/y/E/L -> pad	5.9	ns	50 pf load
Output, Medium	$t_{PD}$ (Maximum)	x/y/E/L -> pad	4.8	ns	50 pf load
Output, Fast	$t_{PD}$ (Maximum)	x/y/E/L -> pad	3.9	ns	50 pf load
Output, Slow	$t_{PZX}$ (Maximum)	oe -> pad	6.2	ns	50 pf load
Output, Slow	$t_{PXZ}$ (Maximum)	oe -> pad	1.3	ns	50 pf load
Output, Medium	$t_{PZX}$ (Maximum)	oe -> pad	4.8	ns	50 pf load
Output, Medium	$t_{PXZ}$ (Maximum)	oe -> pad	1.9	ns	50 pf load
Output, Fast	$t_{PZX}$ (Maximum)	oe -> pad	3.7	ns	50 pf load
Output, Fast	$t_{PXZ}$ (Maximum)	oe -> pad	1.6	ns	50 pf load

## FreeRAM Asynchronous Timing Characteristics

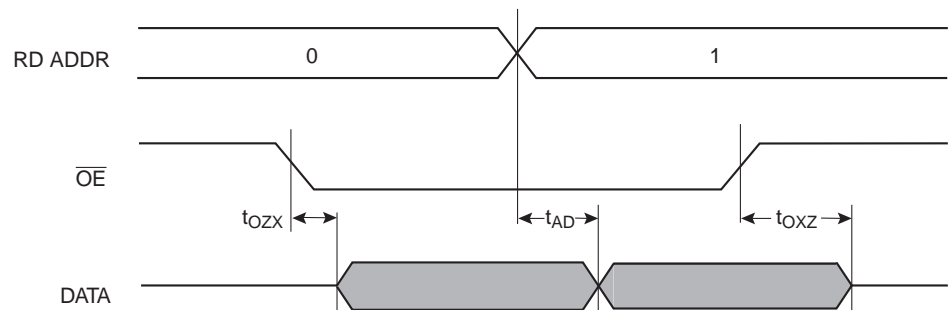
### Single-port Write/Read



### Dual-port Write with Read



### Dual-port Read



AT40K05AL	AT40K10AL	AT40K20AL	AT40K40AL	Left Side (Top to Bottom)				
128 I/O	192 I/O	256 I/O	384 I/O	84 PLCC	100 TQFP	144 LQFP	208 PQFP	240 PQFP
I/O9, FCK1	I/O13, FCK1	I/O17, FCK1	I/O25, FCK1			9	15	15
I/O10	I/O14	I/O18	I/O26			10	16	16
I/O11 (A20)	I/O15 (A20)	I/O19 (A20)	I/O27 (A20)	17	6	11	17	17
I/O12 (A21)	I/O16 (A21)	I/O20 (A21)	I/O28 (A21)	18	7	12	18	18
	VCC	VCC	VCC					19
	I/O17	I/O21	I/O29					20
	I/O18	I/O22	I/O30					21
			GND					
			I/O31					
			I/O32					
			I/O33					
			I/O34					
		I/O23	I/O35					
		I/O24	I/O36					
		GND	GND					22
			VCC					
			I/O37					
			I/O38					
		I/O25	I/O39					
		I/O26	I/O40					
	I/O19	I/O27	I/O41				19	23
	I/O20	I/O28	I/O42				20	24
			GND					
I/O13	I/O21	I/O29	I/O43			13	21	25
I/O14	I/O22	I/O30	I/O44		8	14	22	26
			I/O45					
			I/O46					
I/O15 (A22)	I/O23 (A22)	I/O31 (A22)	I/O47 (A22)	19	9	15	23	27
I/O16 (A23)	I/O24 (A23)	I/O32 (A23)	I/O48 (A23)	20	10	16	24	28
GND	GND	GND	GND	21	11	17	25	29
VCC	VCC	VCC	VCC	22	12	18	26	30

Note: 1. On-chip tri-state

AT40K05AL	AT40K10AL	AT40K20AL	AT40K40AL	Bottom Side (Left to Right)				
128 I/O	192 I/O	256 I/O	384 I/O	84 PLCC	100 TQFP	144 LQFP	208 PQFP	240 PQFP
VCC	VCC	VCC	VCC	33	25	37	55	61
M2	M2	M2	M2	34	26	38	56	62
I/O33, GCK3	I/O49, GCK3	I/O65, GCK3	I/O97, GCK3	35	27	39	57	63
I/O34 (HDC)	I/O50 (HDC)	I/O66 (HDC)	I/O98 (HDC)	36	28	40	58	64
I/O35	I/O51	I/O67	I/O99			41	59	65
I/O36	I/O52	I/O68	I/O100			42	60	66
I/O37	I/O53	I/O69	I/O101		29	43	61	67
I/O38 (LDC)	I/O54 (LDC)	I/O70 (LDC)	I/O102 (LDC)	37	30	44	62	68
			GND					
			I/O103					
			I/O104					
			I/O105					
			I/O106					
		I/O71	I/O107					
		I/O72	I/O108					
		VCC	VCC					
		GND	GND					
I/O39	I/O55	I/O73	I/O109				63	69
I/O40	I/O56	I/O74	I/O110				64	70
	I/O57	I/O75	I/O111				65	71
	I/O58	I/O76	I/O112				66	72
			I/O113					
			I/O114					
			GND					
		I/O77	I/O115					
		I/O78	I/O116					
	I/O59	I/O79	I/O117					73
	I/O60	I/O80	I/O118					74
			I/O119					
			I/O120					
GND	GND	GND	GND			45	67	75
I/O41	I/O61	I/O81	I/O121			46	68	76



AT40K05AL	AT40K10AL	AT40K20AL	AT40K40AL	Right Side (Bottom to Top)				
128 I/O	192 I/O	256 I/O	384 I/O	84 PLCC	100 TQFP	144 LQFP	208 PQFP	240 PQFP
VCC	VCC	VCC	VCC	54	51	73	106	121
$\overline{\text{RESET}}$	$\overline{\text{RESET}}$	$\overline{\text{RESET}}$	$\overline{\text{RESET}}$	55	52	74	108	122
I/O65 (D7)	I/O97 (D7)	I/O129 (D7)	I/O193 (D7)	56	53	75	109	123
I/O66, GCK5	I/O98, GCK5	I/O130, GCK5	I/O194, GCK5	57	54	76	110	124
I/O67	I/O99	I/O131	I/O195			77	111	125
I/O68	I/O100	I/O132	I/O196			78	112	126
		I/O133	I/O197					
		I/O134	I/O198					
			GND					
	I/O101	I/O135	I/O199					127
	I/O102	I/O136	I/O200					128
			I/O201					
			I/O202					
			I/O203					
			I/O204					
		VCC	VCC					
		GND	GND					
I/O69 (D6)	I/O103 (D6)	I/O137 (D6)	I/O205 (D6)	58	55	79	113	129
I/O70	I/O104	I/O138	I/O206		56	80	114	130
I/O71	I/O105	I/O139	I/O207				115	131
I/O72	I/O106	I/O140	I/O208				116	132
			I/O209					
			I/O210					
			GND					
			I/O211					
			I/O212					
	I/O107	I/O141	I/O213				117	133
	I/O108	I/O142	I/O214				118	134
		I/O143	I/O215					
		I/O144	I/O216					
GND	GND	GND	GND			81	119	135
	I/O109	I/O145	I/O217					136
	I/O110	I/O146	I/O218					137

AT40K05AL	AT40K10AL	AT40K20AL	AT40K40AL	Top Side (Right to Left)				
128 I/O	192 I/O	256 I/O	384 I/O	84 PLCC	100 TQFP	144 LQFP	208 PQFP	240 PQFP
GND	GND	GND	GND	76	77	110	160	182
I/O97 (A0)	I/O145 (A0)	I/O193 (A0)	I/O289 (A0)	77	78	111	161	183
I/O98, GCK7 (A1)	I/O146, GCK7 (A1)	I/O194, GCK7 (A1)	I/O290, GCK7 (A1)	78	79	112	162	184
I/O99	I/O147	I/O195	I/O291			113	163	185
I/O100	I/O148	I/O196	I/O292			114	164	186
			I/O293					
			I/O294					
			GND					
			I/O295					
			I/O296					
I/O101 ( $\overline{\text{CS1}}$ , A2)	I/O149 ( $\overline{\text{CS1}}$ , A2)	I/O197 ( $\overline{\text{CS1}}$ , A2)	I/O297 ( $\overline{\text{CS1}}$ , A2)	79	80	115	165	187
I/O102 (A3)	I/O150 (A3)	I/O198 (A3)	I/O298 (A3)	80	81	116	166	188
		I/O199	I/O299					
		I/O200	I/O300					
		VCC	VCC					
		GND	GND					
	I/O151 <sup>(1)</sup>	I/O201 <sup>(1)</sup>	I/O301 <sup>(1)</sup>	75 <sup>(1)</sup> NC	76 <sup>(1)</sup> NC	109 <sup>(1)</sup> NC	159 <sup>(1)</sup> NC	189 <sup>(1)</sup> NC
	I/O152	I/O202	I/O302					190
I/O103	I/O153	I/O203	I/O303			117	167	191
I/O104 <sup>(1)</sup>	I/O154	I/O204	I/O304				168	192
			I/O305					
			I/O306					
			GND					
			I/O307					
			I/O308					
	I/O155	I/O205	I/O309				169	193
	I/O156	I/O206	I/O310				170	194
		I/O207	I/O311					195
		I/O208	I/O312					
GND	GND	GND	GND			118	171	196

Note: 1. Shared with TSTCLK. No Connect.



## AT40K05AL Ordering Information

Usable Gates	Operating Voltage	Speed Grade (ns)	Ordering Code	Package	Operation Range <sup>(1)</sup>
5,000 - 10,000	3.3V	1	AT40K05AL-1AJC	84J	Commercial (0°C to 70°C)
			AT40K05AL-1AQC	100T1	
			AT40K05AL-1BQC	144L1	
			AT40K05AL-1DQC	208Q1	
5,000 - 10,000	3.3V	1	AT40K05AL-1AJI	84J	Industrial (-40°C to 85°C)
			AT40K05AL-1AQI	100T1	
			AT40K05AL-1BQI	144L1	
			AT40K05AL-1DQI	208Q1	

## AT40K10AL Ordering Information

Usable Gates	Operating Voltage	Speed Grade (ns)	Ordering Code	Package	Operation Range <sup>(1)</sup>
10,000 - 20,000	3.3V	1	AT40K10AL-1AJC	84J	Commercial (0°C to 70°C)
			AT40K10AL-1AQC	100T1	
			AT40K10AL-1BQC	144L1	
			AT40K10AL-1DQC	208Q1	
10,000 - 20,000	3.3V	1	AT40K10AL-1AJI	84J	Industrial (-40°C to 85°C)
			AT40K10AL-1AQI	100T1	
			AT40K10AL-1BQI	144L1	
			AT40K10AL-1DQI	208Q1	

## AT40K20AL Ordering Information

Usable Gates	Operating Voltage	Speed Grade (ns)	Ordering Code	Package	Operation Range <sup>(1)</sup>
20,000 - 30,000	3.3V	1	AT40K20AL-1AJC	84J	Commercial (0°C to 70°C)
			AT40K20AL-1AQC	100T1	
			AT40K20AL-1BQC	144L1	
			AT40K20AL-1DQC	208Q1	
20,000 - 30,000	3.3V	1	AT40K20AL-1AJI	84J	Industrial (-40°C to 85°C)
			AT40K20AL-1AQI	100T1	
			AT40K20AL-1BQI	144L1	
			AT40K20AL-1DQI	208Q1	

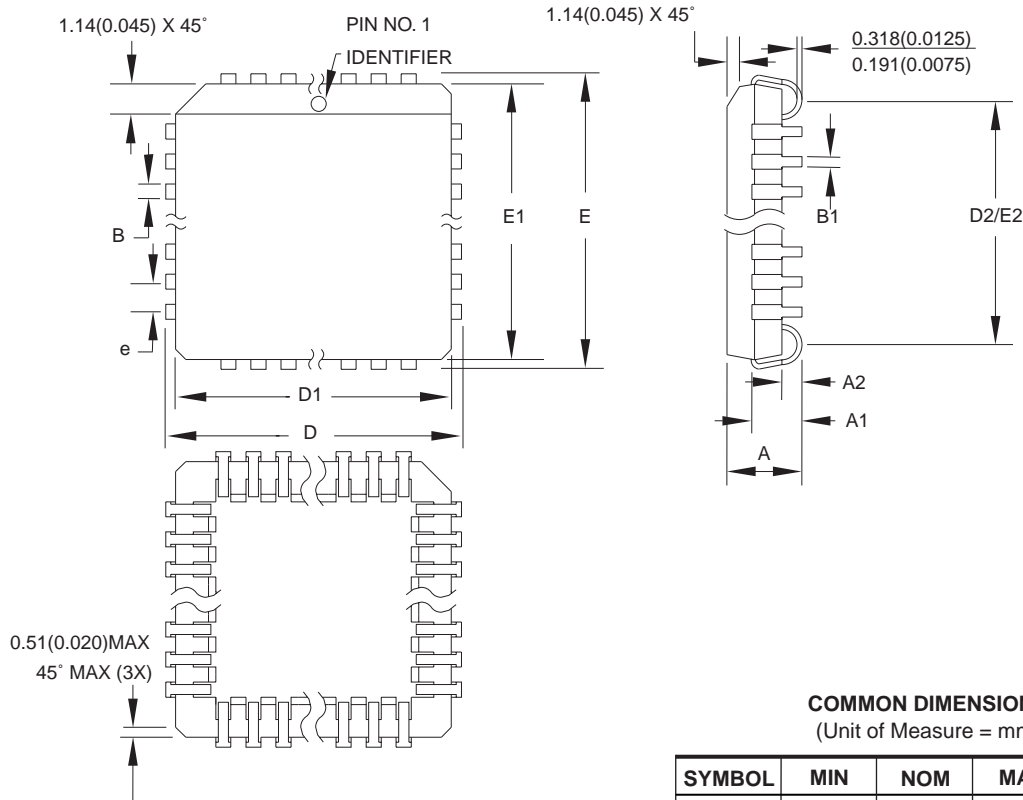
## AT40K40AL Ordering Information

Usable Gates	Operating Voltage	Speed Grade (ns)	Ordering Code	Package	Operation Range <sup>(1)</sup>
40,000 - 50,000	3.3V	1	AT40K40AL-1BQC	144L1	Commercial (0°C to 70°C)
			AT40K40AL-1DQC	208Q1	
			AT40K40AL-1EQC	240Q1	
40,000 - 50,000	3.3V	1	AT40K40AL-1BQI	144L1	Industrial (-40°C to 85°C)
			AT40K40AL-1DQI	208Q1	
			AT40K40AL-1EQI	240Q1	

Note: 1. For military parts, contact Atmel at [fpga@atmel.com](mailto:fpga@atmel.com).

## Packaging Information

### 84J – PLCC



**COMMON DIMENSIONS**  
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	4.191	—	4.572	
A1	2.286	—	3.048	
A2	0.508	—	—	
D	30.099	—	30.353	
D1	29.210	—	29.413	Note 2
E	30.099	—	30.353	
E1	29.210	—	29.413	Note 2
D2/E2	27.686	—	28.702	
B	0.660	—	0.813	
B1	0.330	—	0.533	
e	1.270 TYP			

- Notes:
1. This package conforms to JEDEC reference MS-018, Variation AF.
  2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is .010" (0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
  3. Lead coplanarity is 0.004" (0.102 mm) maximum.

10/04/01



2325 Orchard Parkway  
San Jose, CA 95131

#### TITLE

**84J**, 84-lead, Plastic J-leaded Chip Carrier (PLCC)

#### DRAWING NO.

84J

#### REV.

B





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